

# Peter Zaumseil

## List of Publications by Year in descending order

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Version: 2024-02-01

18

papers

269

citations

933447

10

h-index

940533

16

g-index

18

all docs

18

docs citations

18

times ranked

391

citing authors

#	ARTICLE	IF	CITATIONS
1	Temperature dependence of strain-phonon coefficient in epitaxial Ge/Si(001): A comprehensive analysis. <i>Journal of Raman Spectroscopy</i> , 2020, 51, 989-996.	2.5	20
2	Composition analysis and transition energies of ultrathin Sn-rich GeSn quantum wells. <i>Physical Review Materials</i> , 2020, 4, .	2.4	10
3	Morphological evolution of Ge/Si nano-strips driven by Rayleigh-like instability. <i>Applied Physics Letters</i> , 2018, 112, 022101.	3.3	10
4	Gate stack and Ni(SiGeSn) metal contacts formation on low bandgap strained (Si)Ge(Sn) semiconductors. , 2018, , .		2
5	Photoluminescence from GeSn nano-heterostructures. <i>Nanotechnology</i> , 2018, 29, 415702.	2.6	9
6	Structural analysis of a phosphide-based epitaxial structure with a buried oxidized AlAs sacrificial layer. <i>Journal of Applied Physics</i> , 2017, 121, 215303.	2.5	0
7	Schottky barrier tuning <i>via</i> dopant segregation in NiGeSn-GeSn contacts. <i>Journal of Applied Physics</i> , 2017, 121, .	2.5	20
8	Dislocation-free Ge Nano-crystals via Pattern Independent Selective Ge Heteroepitaxy on Si Nano-Tip Wafers. <i>Scientific Reports</i> , 2016, 6, 22709.	3.3	25
9	Selective growth of fully relaxed GeSn nano-islands by nanoheteroepitaxy on patterned Si(001). <i>Applied Physics Letters</i> , 2016, 109, .	3.3	10
10	Characterization of reclaimed GaAs substrates and investigation of reuse for thin film InGaAlP LED epitaxial growth. <i>Journal of Applied Physics</i> , 2016, 120, 045301.	2.5	7
11	Photodetection in Hybrid Single-Layer Graphene/Fully Coherent Germanium Island Nanostructures Selectively Grown on Silicon Nanotip Patterns. <i>ACS Applied Materials &amp; Interfaces</i> , 2016, 8, 2017-2026.	8.0	32
12	Sn migration control at high temperature due to high deposition speed for forming high-quality GeSn layer. <i>Applied Physics Express</i> , 2016, 9, 031201.	2.4	11
13	Fabrication of GeSn-multiple quantum wells by overgrowth of Sn on Ge by using molecular beam epitaxy. <i>Applied Physics Letters</i> , 2015, 107, .	3.3	12
14	Ternary and quaternary Ni(Si)Ge(Sn) contact formation for highly strained Ge p- and n-MOSFETs. <i>Semiconductor Science and Technology</i> , 2015, 30, 055003.	2.0	28
15	Fully coherent growth of Ge on free-standing Si(001) nanomesas. <i>Physical Review B</i> , 2014, 89, .	3.2	32
16	Compliant Si nanostructures on SOI for Ge nanoheteroepitaxy-A case study for lattice mismatched semiconductor integration on Si(001). <i>Journal of Applied Physics</i> , 2012, 112, 043506.	2.5	13
17	About the strain state of different metal oxide layers epitaxially grown on Si(100). <i>Journal Physics D: Applied Physics</i> , 2011, 44, 055403.	2.8	12
18	A complex x-ray characterization of heteroepitaxial silicon/insulator/silicon(111) structures. <i>Journal of Applied Physics</i> , 2008, 104, .	2.5	16